

Search Notes



Application/Control No.

09/703,792

Examiner

CHUONG T. HO

Applicant(s)/Patent under
Reexamination

HAYAKAWA ET AL.

Art Unit

2616

SEARCHED

Class	Subclass	Date	Examiner
370	229 ↓ 232	03/26/07	CH
370	234		
370	235		
370	235.1		
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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
WEST (Text search, class search) EAST	03/26/07	CH
STN IEEE		